

**Notice of References Cited**

Application/Control No.

09/677,061

Applicant(s)/Patent Under  
Reexamination  
DELMONICO, JAMES J.

Examiner

Christopher E. Lee

Art Unit

2189

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,145,036 A	11-2000	Barenys et al.	710/300
	B	US-5,613,090 A	03-1997	Willems, Richard A.	709/329
	C	US-6,414,956 B1	07-2002	Szczepanek, Andre	370/392
	D	US-6,219,691 B1	04-2001	Youn, Sunny M.	709/200
	E	US-5,586,269 A	12-1996	Kubo, Seiichi	340/825.52
	F	US-5,949,786 A	09-1999	Bellenger, Donald M.	370/401
	G	US-5,884,044 A	03-1999	Marsanne et al.	709/232
	H	US-6,145,102 A	11-2000	Klein et al.	714/47
	I	US-5,897,663 A	04-1999	Stancil, Charles J.	711/200
	J	US-6,205,504 B1	03-2001	Faust et al.	710/305
	K	US-6,233,635 B1	05-2001	Son, Ho-kyu	710/315
	L	US-6,202,115 B1	03-2001	Khosrowpour, Farzad	710/312
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.